



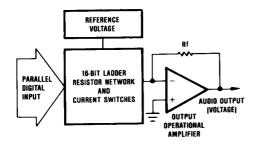
PCM53JP, KP

DESIGNED FOR AUDIO

16-Bit Monolithic DIGITAL-TO-ANALOG CONVERTER

FEATURES

- LOW COST
- NO EXTERNAL COMPONENTS REQUIRED
- 16-RIT RESOLUTION
- 16-BIT MONOTONICITY. typ
- 0.001% OF FSR TYP DIFFERENTIAL LINEARITY ERROR
- 0.0025% max THO (FS Input, KP Grade, 16 Bits)
- 0.02% max THD (-20dB Input, KP Grade, 16 Bits)
- 3usec SETTLING TIME, typ
- 96dB DYNAMIC RANGE
- ±10V AUDIO GUTPUT
- FIAJ STC-007 COMPATIBLE
- INDUSTRY-STANDARD PINOUT
- COMPACT, PLASTIC DIP PACKAGE



DESCRIPTION

The PCM53 family of converters are state-of-theart, fully monolithic, digital-to-analog converters that are designed and specified for digital audio applications. These devices employ a segmented architecture and ultra-stable, nichrome (NiCr), thinfilm, well-matched resistors to provide monotonicity, low distortion, and low differential linearity error (especially around bipolar zero) over long periods of time and over the full operating temperature range.

The PCM53 converters are completely self-contained with stable, low noise, internal, zener voltage reference; high speed current switches; resistor ladder network; and fast-settling, low noise, output operational amplifier all on a single monolithic chip. A special, open-loop reference circuit helps provide the fast settling time required for critical audio applications. The converters can be operated using two power supplies (±15V) instead of three separate supplies. Few external components are necessary for operation, and all critical specifications are 100% tested. This helps to assure the user of high system reliability and outstanding overall system performance.

The current output models settle to within $\pm 0.006\%$ of FSR final value in typically 350nsec in response to a full-scale change in the digital input code.

These converters are packaged in a high-quality molded plastic package and have passed operating life tests under simultaneous high-pressure, hightemperature and high humidity conditions.

The letters V and I (e.g. PCM53JP-V and PCM53KP-I) refer to the voltage-output and current-output models respectively.

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SPECIFICATIONS

ELECTRICAL

T_A = +25°C rated power supplies unless otherwise noted.

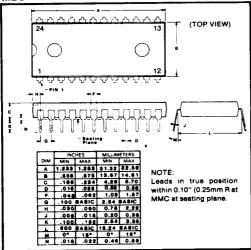
MODEL	PCM53JP-I, -V		PCM53KP-I, -V		ĺ		
	MIN	TYP	MAX	MIN	TYP	MAX	UNITS
INPUT							
DIGITAL INPUT						ŀ	
Resolution		16			•		Bits
Dynamic Range	1	96			•		dB
Logic Levels (TTL/CMOS Compatible: Logic "1" at +40µA	+2.4		+V _{cc}	•		1	VDC
Logic "0" at -0.5mA	.0		+0.8	•		<u> </u>	VDC
TRANSFER CHARACTERISTICS							
ACCURACY						±1.0	 %
Gain Error		±0.1 ±10	±2.5 ±200			±50	l mv
Bipolar Zero Error ⁽¹⁾		0.001	0.005			0.003	% of FSR ⁽²⁾
Differential Linearity Error at Bipolar Zero		30	60			0.003	μν
Noise (rms)(20Hz to 20kHz) at Bipolar Zero (Vout models)		30	80			 	
TOTAL HARMONIC DISTORTION(3) (16-Bit Resolution)		0.002	0.004			0.0025	%
$V_o = \pm FS$ at $f = 420Hz$		0.002	0.004	l .		0.02	%
$V_0 = -20 dB at f = 420 Hz$		1.9	4.0	l .		2.0	%
V _o = -60dB at f = 420Hz			4.0			2.0	Bits
MONOTONICITY		16					Bits
DRIFT (0°C to +70°C) Total Bipolar Drift (includes gain, offset, and linearity drift)		±25	±150				ppm of FSR/°
Total Bipolar Drift (Includes gain, onset, and illearity drift)		±0.1	±0.68				% of FSR
		±0.01	±0.06	1			dB
Bipolar Zero Drift		±4	±20		•	•	ppm of FSR/°
SETTLING TIME (to ±0.006% of FSR)							
Voltage Models Output: 10V Step	ļ	3			•		μsec
1LSB Step	į.	1			•	i	μsec
Current Models Output (1mA Step): 10Ω to 100Ω Load		350			•		nsec
1kΩ Load ⁽⁴⁾	,	350				1	nsec
Deglitcher Delay (THD Test) ¹⁵¹	i	2.5	4.0		•	1 .	μsec
Slew Rate		10			•	<u></u>	V/µsec
WARM-UP TIME	1			•		<u> </u>	Min
OUTPUT							
ANALOG OUTPUT	İ						i
Voltage Models: Output Voltage Range	±9.75	±10	±10.25	±9.90	•	±10.1	V
Output Current	±5	ļ	1				mA
Output Impedance	l .	0.1	•				Ω
Short-Circuit Duration	Indef	inite to Co	mmon				1 .
Current Models: Output Current Range(±30%)		1 ±1		ŀ		1	mA
Output Impedance (±30%)	L	2.4	L	l		1	kΩ
POWER SUPPLY	г		т			т	
SENSITIVITY		±0.001	1	1		1	% of FSR/%V
+V _{cc}	1	±0.001	1			1	% of FSR/%V
-V _{cc}		±0.001	1	ł		1	% of FSR/%V
V _{DD}	1	10.001	 	<u> </u>		 	,3 01 1 G1 1/ 70 V
POWER SUPPLY REQUIREMENTS	±14.25	±15	±15.75	.		.	VDC
Voltage: ±V _{cc} ⁽⁶⁾	+4.75	+5	+15.75				VDC
$V_{DD}^{(6)}$ (V _{DD} may be connected to +V _{CC} supply voltage. Result is slightly	+4./3	+3	1 13.73				1
increased total power dissipation of approximately 40mW).			1	İ			
Supply Drain (no load): +V _{cc} ^(e)	1	+18	+30	l		1 .	mA
-V _{cc} ⁽⁶⁾	I	-18	-30	l			mA
- vcc V _{D0} ⁽⁶⁾		+4	+10			•	mA
TEMPERATURE RANGE							
Specification	0		+70			1:	°c
Operating	-25		+85				

NOTES: (1) Adjustable to zero with external potentiometer. (2) FSR means Full-Scale Range and is 20V for ±10V voltage output models and 2mA for ±1mA current output models. (3) The measurement of total harmonic distortion is highly dependent on the characteristics of the measurement circuif. A block diagram of a measurement circuit is shown in Figure 2. Burr-Brown may calculate THD from the measured linearity errors using equation 2 in the section on "Total Harmonic Distortion," but specifies that the maximum THD measured with the circuit shown in Figure 2 will be less than the limits indicated. (4) Measured with an active clamp to provide a low impedance for approximately 200nsec. (5) Deglitcher or Sample/Hold delay used in THD measurement test circuit. See Figures 2 and 3. (6) See Connection Diagram and Pin Assignments.

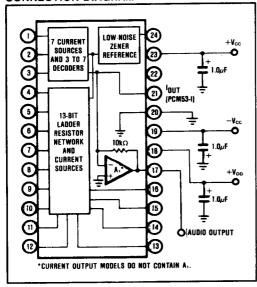
ABSOLUTE MAXIMUM RATINGS

DC Supply Voltages
Lead Temperature During Soldering 10sec at +300°C

MECHANICAL



CONNECTION DIAGRAM



PIN ASSIGNMENTS

Pin No.	PCM53KP-V, PCM53JP-V	PCM53KP-I, PCM53JP-I
1	Bit 1 (MSB)	Bit 1 (MSB)
2	Bit 2	Bit 1
3	Bit 3	Bit 3
4	Bit 4	Bit 4
5	Bit 5	Bit 5
6	Bit 6	Bit 6
7	Bit 7	Bit 7
8	Bit 8	Bit 8
9	Bit 9	Bit 9
10	Bit 10	Bit 10
11	Bit 11	Bit 11
12	Bit 12	Bit 12
13	Bit 13	Bit 13
14	Bit 14	Bit 14
15	Bit 15	Bit 15
16	Bit 16 (LSB)	Bit 16 (LSB)
17	±10V Audio Out	R ₁ (10kΩ ±30%)
18	V _{DD}	Von
19	-Vcc	-V _{cc}
20	Common	Common
21	Summing Junction	Ι _{ουτ} , ±1mA ±30%
		(Audio Output)
22	Test Point	Test Point
23	+Vcc	-Vcc
24	Reference Out (+6.3V)	Reference Out (+6.3V)

ORDERING INFORMATION

Model No.	Output Configuration		
PCM53JP-I	±1mA		
PCM53KP-I	±1mA		
PCM53JP-V	±10V		
PCM53KP-V	±10V		

THEORY OF OPERATION AND AUDIO SPECIFICATIONS

The transfer function of an ideal binary D/A converter is a set of discrete output levels that lie on a straight line as shown in Figure I. The number of possible discrete output levels, or resolution, is equal to 2ⁿ where n is the number of digital inputs or "bits". The PCM53 has 2¹⁶ or 65,536 possible output levels. Another method of expressing resolution that is useful in audio applications is Dynamic Range.

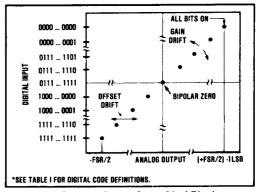


FIGURE I. Input vs Output for an Ideal Bipolar D/A Converter.

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DYNAMIC RANGE

The Dynamic Range is a measure of the ratio of the smallest signals the converter can produce to the full-scale range and is usually expressed in decibels (dB). The theoretical dynamic range of a converter is approximately 6 × n, or about 96dB for a 16-bit converter. The actual, or useful, dynamic range is limited by noise and linearity errors and is therefore somewhat less than the theoretical limit. However, this does point out that a resolution of at least 16 bits is required to obtain a 90dB minimum dynamic range, regardless of the accuracy of the converter. Another specification that is useful for audio applications is Total Harmonic Distortion (THD).

TOTAL HARMONIC DISTORTION

THD is useful in audio applications and is a measure of the magnitude and distribution of the Linearity Error, Differential Linearity Error, and Noise, as well as Quantization Error. To be useful, THD should be specified for both high level and low level input signals. This error is unadjustable and is the most meaningful indicator of D/A converter accuracy for audio applications.

The THD is defined as the ratio of the square root of the sum of the squares of the values of the harmonics to the value of the fundamental input frequency and is expressed in percent or dB. A block diagram of the test circuit used to measure the THD of the PCM53 is shown in Figure 2. A timing diagram of the control logic is shown in Figure 3.

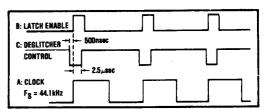


FIGURE 3. Control Logic Timing for PCM53
Distortion Test Circuit.

If we assume that the error due to the test circuit is negligible, then the rms value of the PCM53 error referred to the input can be shown to be

$$\epsilon_{\rm rms} = \sqrt{\frac{1}{n}} \sum_{i=1}^{n} \left[E_{\rm L}(i) + E_{\rm Q}(i) \right]^2 \tag{1}$$

where n is the number of samples in one cycle of any given sine wave, $E_L(i)$ is the linearity error of the PCM53 at each sampling point, and $E_O(i)$ is the quantization error at each sampling point. The THD can then be expressed as

THD =
$$\frac{\epsilon_{rms}}{E_{rms}} = \frac{\sqrt{\frac{1}{f_s}} \sum_{i=1}^{S} [E_L(i) + E_Q(i)]^2}{E_{rms}} \times 100\%$$
 (2)

where E_{rms} is the rms signal-voltage level.

This expression indicates that, in general, there is a correlation between the THD and the square root of the sum of

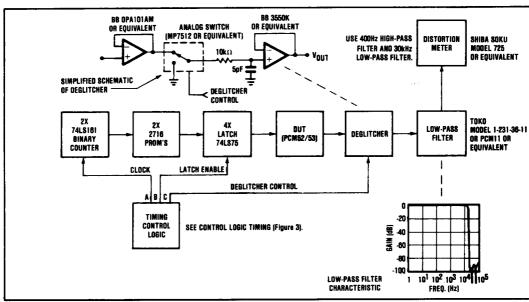


FIGURE 2. Block Diagram of Distortion Test Circuit.

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the squares of the linearity errors at each digital word of interest. However, this expression does not mean that the worst-case linearity error of the D/A is directly correlated to the THD.

For the PCM53 the test period was chosen to be 22.7µsec (44.1kHz) which is compatible with the EIAJ STC-007 specification for PCM audio. The test frequency is 420Hz and the amplitude of the input signal is 0dB, -20dB, and -60dB down from full scale.

Figure 4 shows the typical THD as a function of output voltage.

Figure 5 shows typical THD as a function of frequency.

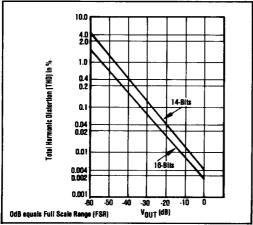


FIGURE 4. Total Harmonic Distortion (THD) vs Vour.

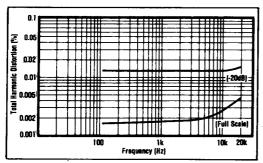


FIGURE 5. Total Harmonic Distortion (THD) vs Frequency.

DIGITAL INPUT CODES

The PCM53 accepts complementary digital input codes in binary format. It may be connected by the user for either complementary offset binary (COB) or complementary two's complement (CTC) codes. See Table I.

TABLE I. Digital Input Codes.

DIGITAL INPUT CODES				
		СОВ	CLC.	
	MSB LSB	Complementary Offset Binary	Complementary Two's Complement	
All bits ON Mid Scale All bits OFF	0000000 0111111 1111111 1000000	+Full Scale Zero -Full Scale -1LSB	-1LSB -Full Scale Zero +Full Scale	

*A TTL inverter must be connected between the MSB input signal and bit 1 (pin 1) to obtain CTC input code.

DETAILED THEORY OF OPERATION

In the basic design, the three functions represented by the complete D/A converter—the voltage reference, the output amplifier, and the converter—are distributed among six major circuit blocks (Figure 6). Three blocks—the open loop reference, the current-offset circuit, and the reference output amplifier—perform the reference functions. The D/A conversion is performed by two circuits called the upper converter and the lower converter, which are combined into the voltage output by the on-chip output op amp.

The prime requirements for a D/A converter circuit designed for PCM audio applications are that it have low differential linearity error and monotonicity and that it stay that way over a useful temperature range. To obtain this performance at 14 to 16 bits, the converter combines segmentation with multiple R-2R networks.

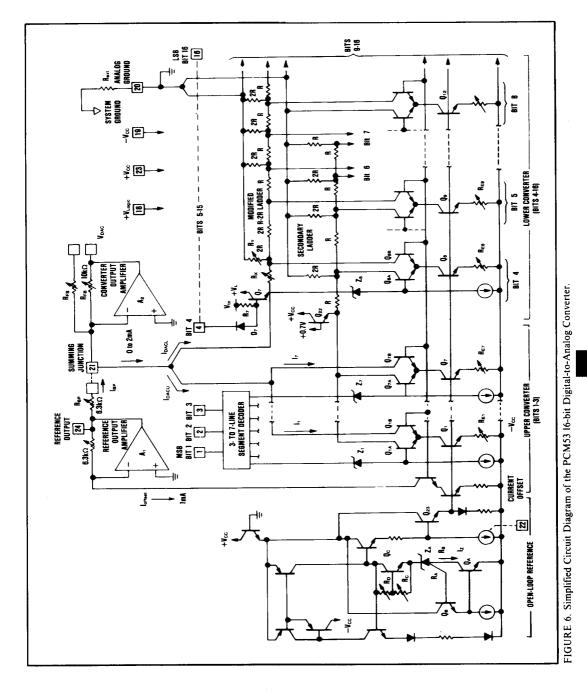
The upper converter, which generates the three most significant bits, is made up of seven equal current sources (Q_1 R_{E1} through Q_7 R_{E7}), each providing 0.25mA. Together the sources form the upper converter current, I_{DACU} .

The three binary-coded MSBs (bits 1, 2, and 3) are decoded by a three-to-seven-line circuit, which sequentially selects the equal current sources as the binary code formed by the bits changes through the eight values (000 to 111). Thus, as the code ranges through its values, IDACU changes from 0 to 1.75mA. This scheme ensures monotonicity, reduces initial matching and tracking requirements, and cuts the tracking errors that occur with temperature and time.

Averaging Transistor and Resistor Shifts

To further improve the tolerance of the upper converter to time and temperature change, the seven equal currents are turned on in the following order: Q_4 , Q_2 , Q_7 , Q_5 , Q_1 , Q_6 , Q_3 . This sequence, which produces the zero-to-full-scale output, averages the shifts that occur in transistor parameters and in the value of the emitter resistors.

The 13 least significant bits are produced by the lower converter, which uses nine more equal-current sources for the nine middle bits and emitter area rationing for the 4LSBs. However, rather than being summed directly by the current of the upper converter (which would have required 2¹⁶ – 1 equal current sources) the current sour-



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ces are further divided binarily by a pair of R-2R networks, called the modified R-2R ladder and the secondary ladder. By diverting the LSB currents through the modified ladder, the lower converter produces I_{DACL} . This current consists of $2^{13}-1$ discrete, 30nA steps for each 0.25mA segment of the upper converter. I_{DACU} and I_{DACL} are added at the summing junction, SJ, to form the I_{DAC} , which has a range that varies between 0 and 1.99997mA.

The modified R-2R ladder is superior to a conventional R-2R ladder because its output can be increased or decreased by laser-trimming of its output resistors (R_X and R_Y). Such trimming does not change the binary current division in the ladder. The gain of the lower converter can then be trimmed relative to the gain of the upper converter without interacting or in any way affecting the linearity of the lower converter.

The initial values of the 16 current sources are determined by the voltage at the output of the reference (the emitter of Q_{23}), but the sources are set to the same value when the emitter resistors (R_1 - R_{16}) are laser-trimmed. The sources are turned on and off by a differential switch pair (such as $Q_{8-}Q_{8-}$) driven by the low-power Schottky TTL-compatible input circuit (typical of D_7 , R_7 , Q_7 , Z_8).

Constant Power

To maintain 16-bit performance, the on-chip power dissipation—and therefore the chip temperature—must be kept constant during code changes. Therefore the current from both the ON side (Q_{1B}) and the OFF side (Q_{1A}) of each differential switch pair in the upper converter should come from $+V_{CC}$, rather than one from $+V_{CC}$ and one from ground. The on-side currents (when the bits are on) come from $+V_{CC}$ and flow through A_2 and the feedback resistor, R_{FB} , to the summing junction to form I_{DACU} . Transistor Q_{22} is used to provide the off-side current with a similar path to $+V_{CC}$. In the lower converter, the secondary R-2R ladder, which is connected between the OFF side of the differential switches and Q_{22} , provides the same function by keeping the $+V_{CC}$ current and the analog ground current constant with code changes.

The secondary ladder also significantly reduces linearity errors that would otherwise be caused by external ground wiring. Indeed, the secondary ladder makes possible the use of a single ground pin, which is the only way to make all the connections in a 24-pin package.

Most converters use a closed-loop op amp for precision DC biasing of their current sources. However, switching transients can cause excessive settling time in the op amp. To ensure minimum settling time, the PCM53 uses an open-loop reference circuit, which incidentally does not require space-consuming capacitors for frequency compensation or suppression of switching transients.

The reference voltage is generated by a Kelvin-sensed buried zener diode. Kelvin sensing is used because the elements of the buried zener, R_A and R_B, have a large and nonlinear temperature coefficient. The Kelvin-sensed connection removes from the reference path the large

voltage drop, R_BI_Z , caused by the ImA zener current I_Z . Instead it substitutes the voltage drop produced across R_A by the base current of Q_B .

Since this base current is only $l\mu A$, the drop is negligible, and the true zener breakdown, V_Z is sensed. In addition great care was taken to ensure that all temperature-sensitive parts of the open-loop reference were laid out along lines of thermal equilibrium, to prevent thermal settling tails.

High-Speed Output Amplifier

In voltage-output models, the output amplifier, A_2 , which sums all of the output currents and converts them into the output voltage, $V_{\rm DAC}$, must be just as accurate as the reference and current sources and just as fast as the switching circuits.

The amplifier is very fast, and it is well behaved when driving a capacitive load. It slews at $10V/\mu$ sec and typically settles to 0.003% of final value in less than 4μ sec for a 20V step. For a step of ILSB at the major carry, it settles in 1.5μ sec. The thermal tails caused by temperature gradients and resistor self-heating are less than 0.001% of full scale.

Thermal tails occur when thermal gradients across the chip change as signal levels change. For example, when driving a load the output stage of the amplifier and its feedback resistor generate more heat at the full-scale output voltage than at zero. Therefore the temperature-sensitive differential input stage, which is close by on the chip, uses cross-coupled transistors and resistors to equalize thermal gradients.

To achieve a $\pm 10V$ output swing when operating from $\pm 15V$, the output stage of the amplifier uses two transistor pairs connected in series. This scheme is necessary because the breakdown voltage of the npn transistors is limited to 20V by the semiconductor process.

In addition, the output stage is biased in a class AB condition, so that current is always flowing. Continuous current flow is essential to ensure that the open-loop gain, A_0 , and closed-loop output impedance, R_0 , remain constant for both positive and negative full-scale output swings at 103dB and 0.03 Ω , respectively. With lesser performance, errors would occur. If, for example, A_0 changed from 94dB to 100dB for an output swing of -10V to +10V respectively, the output error would change by $100\mu V$, and the change would be nonlinear. Likewise a nonlinear error approaching $200\mu V$ would occur if R_0 changed from 0.04Ω to 0.08Ω .

DISCUSSION OF SPECIFICATIONS

The PCM53 is specified to provide critical performance criteria for a wide variety of applications. The most critical specifications for a D/A converter in audio applications are Total Harmonic Distortion, Differential Linearity Error, Bipolar Zero Error, parameter shifts with time and temperature and settling time effects on accuracy.

The PCM53 is factory-trimmed and tested for all critical key specifications.

The accuracy of a D/A converter is described by the transfer function shown in Figure 1. The errors in the D/A converter are combinations of analog errors due to the linear circuitry, matching and tracking properties of the ladder and scaling networks, power supply rejection, and reference errors. In summary, these errors consist of initial errors including Gain, Offset, Linearity, Differential Linearity, and Power Supply Sensitivity. Initial Offset or Bipolar Zero errors may be adjusted to zero. Gain drift over temperature rotates the line (Figure 1) about the bipolar zero point and Offset drift shifts the line left or right over the operating temperature range. Most of the Offset and Gain drift with temperature or time is due to the drift of the internal reference zener diode. The converter is designed so that these drifts are in opposite directions. This way the Bipolar Zero voltage is virtually unaffected by variations in the reference voltage.

BIPOLAR ZERO ERROR

Initial Bipolar Zero Error (Bit 1 "ON" and all other bits "OFF") is the deviation from zero volts out and is factory-trimmed to typically ±10mV at +25°C. This error may be trimmed to zero by connecting the external trim potentiometer shown in Figure 8.

DIFFERENTIAL LINEARITY ERROR

Differential Linearity Error (DLE) is the deviation from an ideal ILSB change from one adjacent output state to the next. DLE is important in audio applications because excessive DLE at Bipolar Zero (at the "major carry") can result in audible crossover distortion for low level output signals. Initial DLE on the PCM53 is factory-trimmed to typically ±0.001% of FSR.

STABILITY WITH TIME AND TEMPERATURE

The parameters of a D/A converter designed for audio applications should be stable over a relatively wide temperature range and over long periods of time to avoid undesirable periodic readjustment. The most important parameters are Bipolar Zero Error, Differential Linearity Error, and Total Harmonic Distortion. Most of the Offset and Gain drift with temperature or time is due to the drift of the internal reference zener diode. The PCM53 is designed so that these drifts are in opposite directions so that the Bipolar Zero voltage is virtually unaffected by variations in the reference voltage. Both DLE and THD are dependent upon the matching and tracking of resistor ratios and upon V_{BE} and hee of the current-source transistors. The PCM53 was designed so that any absolute shift in these components has virtually no effect on DLE or THD. The resistors are made of identical links of ultra-stable nichrome thin-film. The current density in these resistors is very low to further enhance their stability.

POWER SUPPLY SENSITIVITY

Changes in the DC power supplies will affect accuracy.

The PCM53 power supply sensitivity is specified for $\pm 0.01\%$ of FSR/%V_{CC} for all supplies. Normally, regulated power supplies with 1% or less ripple are recommended for use with the DAC. See also Power Supply Connections paragraph in the Installation and Operating Instructions section.

SETTLING TIME

Settling time is the total time (including slew time) required for the output to settle within an error band around its final value after a change in input (see Figure 7).

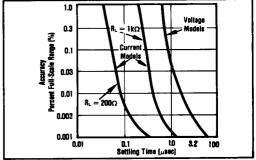


FIGURE 7. Full Scale Range Settling Time vs Accuracy.

Settling times are specified to $\pm 0.006\%$ of FSR; one for a large output voltage change of 10V and one for a ILSB change. The ILSB change is measured at the major carry (0111...11 to 10000...00), the point at which the worst-case settling time occurs.

INSTALLATION AND OPERATING INSTRUCTIONS

POWER SUPPLY CONNECTIONS

For optimum performance and noise rejection, power supply decoupling capacitors should be added as shown in the Connection Diagram. These capacitors (1μ F tantalum or electrolytic recommended) should be located close to the PCM53.

EXTERNAL BIPOLAR ZERO ADJUST (OPTIONAL)

In some applications the Bipolar Zero Error (offset) may require adjustment. This error may be adjusted to zero by installing an external potentiometer as shown in Figure 8. The potentiometer should have adequate resolution, at least 10 turns for full-scale adjustment.

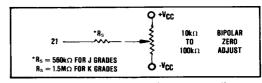


FIGURE 8. Optional External Bipolar Zero Adjust.

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The TCR of the potentiometer should be 100ppm/°C or less. The series resistor, R_S (20% carbon or better) should be located close to the PCM53 to prevent noise pickup. Refer to Figure 9 for the relationship of Bipolar Zero adjust on the D/A converter transfer function.

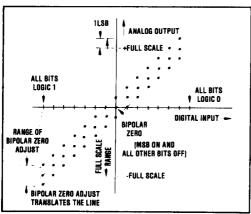


FIGURE 9. Effect of Bipolar Zero Adjustment on a Bipolar D/A Converter Transfer Function.

ADJUSTMENT PROCEDURE

Apply the digital input code that should produce zero volts output (bit 1 or MSB "ON" and all other bits "OFF"). Adjust the bipolar zero potentiometer until zero volts is obtained.

Table II shows the ideal plus and minus full scale voltages and LSB values for both 14- and 16-bits resolution.

TABLE II. Digital Input and Analog Output Relationship.

i	OUTPUT					
	Voltage Model		Curren	Model		
DIGITAL INPUT CODE	16-Bit Resolution	14-Bit Resolution	16-Bit Resolution	14-Bit Resolution		
Complementary		i				
Bipolar Offset	Ì	ľ]		
Binary (COB)	l	l	ļ	1		
±10V (PCM53)						
One LSB	+305µV	+1.22mV	0.031µA	0.122µA		
All Bits On				O. ILLAN		
0000	+9.99969V	+9.99878V	-0.99997mA	-0.99988mA		
All Bits Off			5.555071117	0.00300111A		
1111	-10.00000V	-10.00000V	-1.00000mA	+1.00000mA		

INSTALLATION CONSIDERATIONS

If 14-bit resolution is desired, bit 15 (pin 15) and bit 16 (pin 16) should be connected to $V_{\rm DD}$ through a $1k\Omega$ resistor to insure that these bits remain off.

Figure 10 shows the connection diagram for a PCM53-V. Figures 11 and 12 show connection diagrams for PCM53-I models.

Lead and contact resistances are represented by R_1 through R_3 . As long as the load resistance (R_L) is constant, R_1 simply introduces a gain error. R_2 is part of R_1 if the output voltage is sensed at Common (pin 20) and therefore intro-

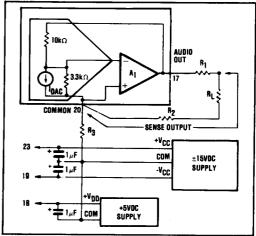


FIGURE 10. Output Circuit for PCM53-V.

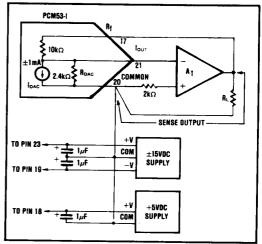


FIGURE II. Preferred External Op Amp Configuration Using PCM53-I.

duces no error. If R_L is variable, then R_L should be less than $R_{L,min}/2^{16}$ to reduce voltage drops due to wiring to less than ILSB. R_L should be located as close as possible to the PCM53 for optimum performance.

The PCM53 and the wiring to its connectors should be located to provide optimum isolation from sources of RFI and EMI. The key word in elimination of RF radiation or pickup is loop area; therefore, signal leads and their return conductors should be kept close together. This reduces the external magnetic field along with any radiation. Also, if a signal lead and its return conductor are wired close together they present a small flux-capture cross section for any external field. This reduces radiation pickup in the circuit.

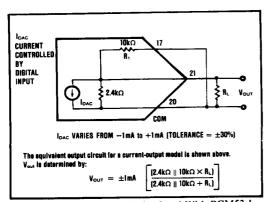


FIGURE 12. Driving a Resistive Load With PCM53-I.

Figures 11 and 12 show connection diagrams for PCM53-I models.

APPLICATIONS

Figures 13 and 14 show a circuit diagram and timing diagram of a single PCM53-V used to obtain both left and right channel audio output in a typical digital audio system. The Sony CX-7934 and associated LSI logic contain all of the required circuitry for error detection,

correction, and formatting of the digital data obtained from the Compact Disc prior to sending this information to the D/A converter. The CX-7934 is used in a parallel output mode where the left and right channel parallel data are time-shared. Since the digital inputs of the PCM53 are TTL-compatible, they can be connected directly to the parallel outputs of the CX-7934. Only a single inverter is required (Bit 1) to convert the two's complement output code of the CX-7934 to offset binary. The audio output of the PCM53-V is alternately time-shared between the left and right channels. The design is greatly simplified because the PCM53-V is a complete D/A converter.

A sample/hold amplifier, or "deglitcher", is required at the output of the D/A converter for both the left and right channel, as shown in Figure 15. The S/H amplifier for the left channel is composed of A₂, SW₁, and associated circuitry. A₂ is used as an integrator to hold the analog voltage in C₁. Since the source and drain of the FET switch operates at a virtual ground when "C" and "B" are closed in the sample mode, there is no increase in distortion caused by the modulation effect of R_{on} by the audio signal.

Figure 16 shows the deglitcher control signals for both the left and right channels which are produced by the timing control logic. A delay of $2.5\mu sec(t\omega)$ is provided to eliminate the glitch and allow the output of the PCM53-V to settle within a small error band around its

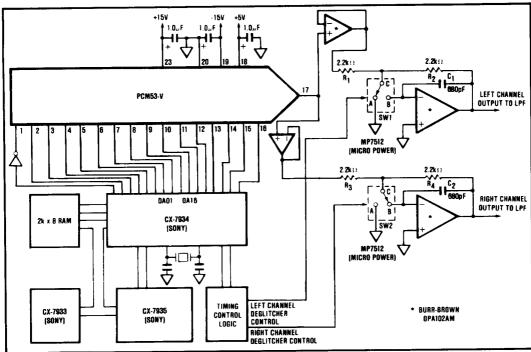


FIGURE 13. A Single PCM52/53 Used to Obtain Both Left and Right Channel Output in a Typical Digital Audio System.

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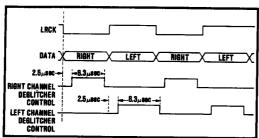


FIGURE 14. Timing Diagram for the Digital Audio System Using PCM53 and Sony LSI Logic.

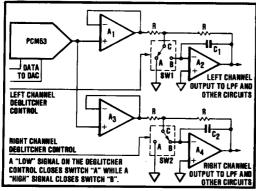


FIGURE 15. A Sample/Hold Amplifier (Deglitcher) is Required at the Digital-to-Analog Output for Both Left and Right Channels.

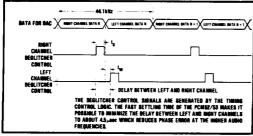


FIGURE 16. Timing Diagram for the Deglitcher Control Signals.

final value before connecting it to the channel output.

Due to the fast settling time of the PCM53-V, it is possible to minimize the delay between the left channel and right channel outputs when using a single D/A converter for both channels. This is important because the left and right channel data is recorded in phase and use of a slower D/A converter would result in significant phase error at the higher audio frequencies.

A low-pass filter is required at the S/H output to remove all unwanted frequency components caused by the sampling frequency as well as the discrete nature of the D A converter output. The filter must have a flat amplitude response over the entire audio band (0 to 20kHz) and a very-high attenuation above 20kHz. Most previous digital audio circuits used a high-order (9-13 pole) analog filter. However, the phase response of an analog filter with these amplitude characteristics is nonlinear and can disturb the pulse-shaped characteristics of the transients contained in music.

SECOND-GENERATION SYSTEMS

One method of avoiding this problem and obtaining a linear phase response is to use an oversampling digital filter technique as shown in Figure 17. The Yamaha YM-3511 and YM-2201 LSI chips provide all of the functions described for the Sony chip set and, in addition, contain an onboard digital oversampling filter which effectively multiplies the sampling frequency by a factor of two and sends the parallel data at a rate of 88.2kHz to the D/A converter. Since the offset binary parallel data is directly available from the YM-2201, no external inverter is required. Furthermore, since the deglitcher control signal is also available from the YM-2201, no external timing control logic is required for most applications. The timing diagram for this circuit is shown in Figure 18.

This circuit requires a very fast D/A converter since the sampling frequency is multiplied by a factor of two or more. This technique results in intermodulation products being created, by mixing the sampling frequency and components of the audio frequency, that are far outside the audio band of 0 to 20kHz. These unwanted frequencies are easily removed by a low-order linear-phase analog filter following the deglitcher circuit, since a sharp amplitude response is not required. A single PCM53-V can be used for both the left and right channel as long as the oversampling rate of the digital filter is two. An oversampling rate of four can be used if a separate PCM53 is used for each channel. This would reduce the complexities of the analog filter required even further (at the expense of an additional D/A converter).

Another factor to consider when choosing a D/A converter for digital audio applications is that the linearity of the total harmonic distortion versus output signal should be good since a change in the background noise level can be audible. The design of the PCM53 ensures that the linearity of the total harmonic distortion versus output signal level is very good over the full range of amplitude and frequencies. Also, no special grounding or shielding techniques are required to obtain good signal-to-noise ratio with the PCM53. Some converters require a high frequency clock which can couple to the analog output of the D/A converter through the output wiring and ground circuitry.

The PCM53 D/A converters provide a complete solution to one of the most critical portions of a digital audio system. Since the sound of the system can be affected by the D/A converter more than any other single component, the selection of which converter to use should be made with care.

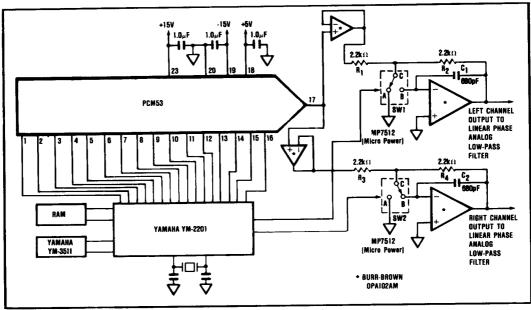


FIGURE 17. Oversampling Digital-Filter Technique Using Yamaha LSI.

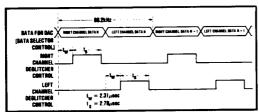


FIGURE 18. Timing Diagram for Digital Oversampling
Technique when using Yamaha LSI.

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